

ALPIDE

Threshold Scans and Noise Occupancy

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21. July 2020

Threshold Scan

Generate digital Pulse in a number of pixels

→ Then read out hits and repeat

- Up to 32 Pixels per Region simultaneously
- Use only a fraction of the Chip (~1-5%)

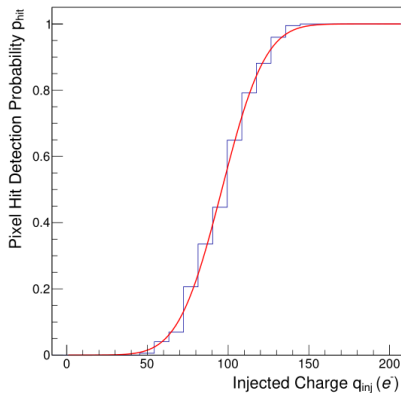
Parameters used:

- PIXPERREGION 1
 - NMASKSTAGES 164
- } Corresponds to $32 \cdot 164 = 5248$ (1% of the chip)

Threshold Scan

50 Injections per charge point, then plot hit probability. (S-Curve scan)

Example:

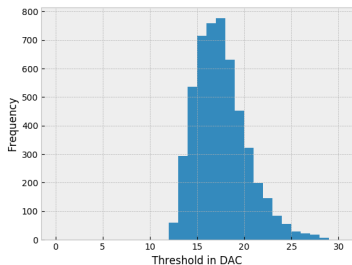


$$p_{Hit}(q_{inj}) = \frac{1}{2} \left(1 + \text{Erf} \left[\frac{q_{inj} - \mu}{\sqrt{2}\sigma} \right] \right)$$

Threshold Scan

- Extract mean

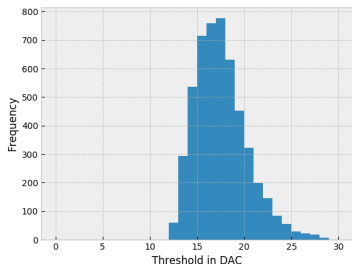
Distribution of Thresholds:



Threshold Scan

- Extract mean
- Repeat with different settings and compare the runs

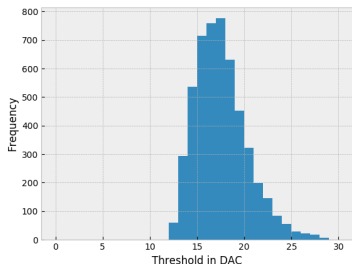
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Distribution of Thresholds:



For cosmic muons at 50 GeV: Energy Deposit ~ 0.0286 MeV
7900 e-h-pairs

Noiseoccupancy Scan

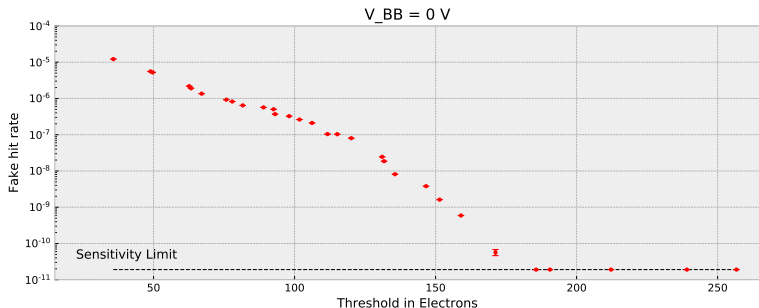
Gives a selectable number of random triggers and returns the number of hits.

- If Threshold is low enough for electronic noise to produce a hit, measurements taken will be affected by a fake hit rate.

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